



5STF 23H2040

Fast Thyristor

Properties

- Amplifying gate
- High operational capability
- Optimized turn-off parameters

Applications

- Power switching applications

Key Parameters

V_{DRM}, V_{RRM}	= 2 000	V
I_{TAV}	= 2 322	A
I_{TSM}	= 42.0	kA
V_{TO}	= 1.516	V
r_T	= 0.111	m Ω
t_q	= 40	μ s

Types

	V_{RRM}, V_{DRM}
5STF 23H2040	2 000 V
Conditions: $T_j = -40 \div 125$ °C, half sine waveform, $f = 50$ Hz, note 1	

Mechanical Data

F_m	Mounting force	50 \pm 5 kN
m	Weight	0.93 kg
D_s	Surface creepage distance	36 mm
D_a	Air strike distance	15 mm

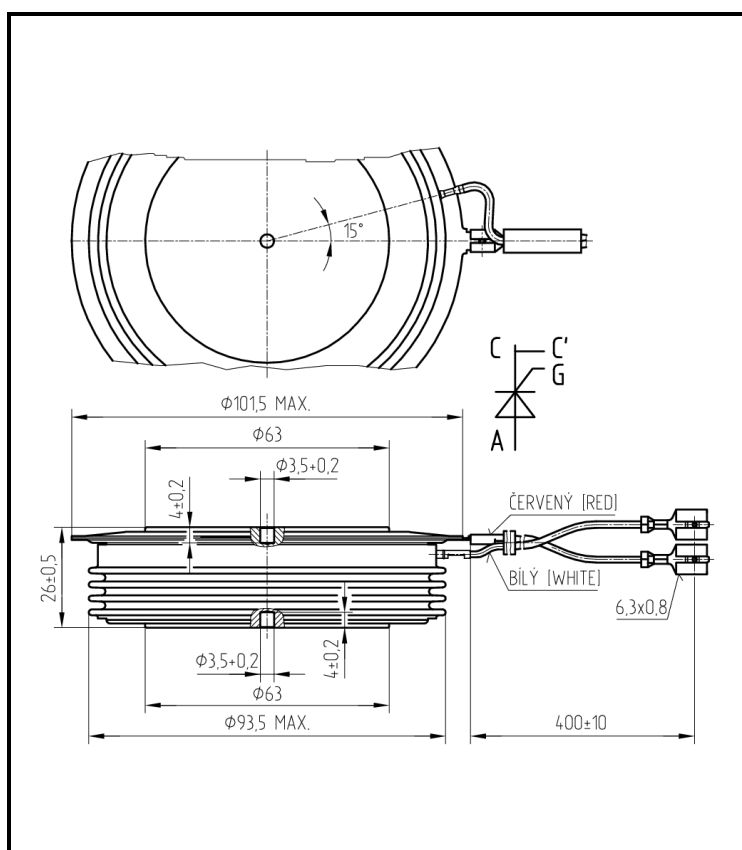


Fig. 1 Case



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Maximum Ratings		Maximum Limits	Unit
V_{RRM} V_{DRM}	Repetitive peak reverse and off-state voltage $T_j = -40 \div 125 \text{ }^\circ\text{C}$, note 1	2 000	V
I_{TRMS}	RMS on-state current $T_c = 70 \text{ }^\circ\text{C}$, half sine waveform, $f = 50 \text{ Hz}$	3 648	A
I_{TAVm}	Average on-state current $T_c = 70 \text{ }^\circ\text{C}$, half sine waveform, $f = 50 \text{ Hz}$	2 322	A
I_{TSM}	Peak non-repetitive surge half sine pulse, $V_R = 0 \text{ V}$	$t_p = 10 \text{ ms}$ 42 000 $t_p = 8.3 \text{ ms}$ 44 900	A
$\hat{P}t$	Limiting load integral half sine pulse, $V_R = 0 \text{ V}$	$t_p = 10 \text{ ms}$ 8 820 000 $t_p = 8.3 \text{ ms}$ 8 370 000	A²s
$(di_T/dt)_{cr}$	Critical rate of rise of on-state current $I_T = I_{TAVm}$, half sine waveform, $f = 50 \text{ Hz}$, $V_D = 2/3 V_{DRM}$, $t_r = 0.3 \text{ } \mu\text{s}$, $I_{GT} = 2 \text{ A}$	800	A/μs
$(dv_D/dt)_{cr}$	Critical rate of rise of off-state voltage $V_D = 2/3 V_{DRM}$	1 000	V/μs
P_{GAVm}	Maximum average gate power losses	3	W
I_{FGM}	Peak gate current	10	A
V_{FGM}	Peak gate voltage	12	V
V_{RGM}	Reverse peak gate voltage	10	V
$T_{jmin} - T_{jmax}$	Operating temperature range	-40 \div 125	$^\circ\text{C}$
$T_{stgmin} - T_{stgmax}$	Storage temperature range	-40 \div 125	$^\circ\text{C}$

Unless otherwise specified $T_j = 125 \text{ }^\circ\text{C}$

Note 1: De-rating factor of 0.13% V_{RRM} or V_{DRM} per $^\circ\text{C}$ is applicable for T_j below $25 \text{ }^\circ\text{C}$

Characteristics			Value			Unit
			min.	typ.	max.	
V_{TM}	Maximum peak on-state voltage	$I_{TM} = 2\,000\text{ A}$ $I_{TM} = 4\,000\text{ A}$			1.680 1.970	V
V_{T0}	Threshold voltage				1.516	V
r_T	Slope resistance				0.111	mΩ
	$I_{T1} = 3\,613\text{ A}, I_{T2} = 10\,838\text{ A}$					
I_{DM}	Peak off-state current				150	mA
	$V_D = V_{DRM}$					
I_{RM}	Peak reverse current				150	mA
	$V_R = V_{RRM}$					
t_{gd}	Delay time				2.0	μs
	$T_j = 25\text{ °C}, V_D = 0.4 V_{DRM}, I_{TM} = I_{TAVM},$ $t_r = 0.3\text{ μs}, I_{GT} = 2\text{ A}$					
t_{q1}	Turn-off time				40.0	μs
	$I_T = 1\,000\text{ A}, di_T/dt = -50\text{ A/μs},$ $V_R = 100\text{ V}, V_D = 2/3 V_{DRM},$ $dv_D/dt = 50\text{ V/μs}$					
t_{q2}	Turn-off time				60.0	μs
	$I_T = 1\,000\text{ A}, di_T/dt = -50\text{ A/μs},$ $V_R = 100\text{ V}, V_D = 0.8 V_{DRM},$ $dv_D/dt = 400\text{ V/μs}$					
Q_{rr}	Recovery charge				1200	μC
	the same conditions as at t_{q1}					
I_{rrM}	Reverse recovery current				290	A
	the same conditions as at t_{q1}					
I_H	Holding current	$T_j = 25\text{ °C}$ $T_j = 125\text{ °C}$			250 150	mA
I_L	Latching current	$T_j = 25\text{ °C}$ $T_j = 125\text{ °C}$			500 300	mA
V_{GT}	Gate trigger voltage	$T_j = -40\text{ °C}$ $T_j = 25\text{ °C}$ $T_j = 125\text{ °C}$			4 3 2	V
	$V_D = 12\text{ V}, I_T = 4\text{ A}$		0.25			
I_{GT}	Gate trigger current	$T_j = -40\text{ °C}$ $T_j = 25\text{ °C}$ $T_j = 125\text{ °C}$			1000 500 300	mA
	$V_D = 12\text{ V}, I_T = 4\text{ A}$		10			

Unless otherwise specified $T_j = 125\text{ °C}$

Thermal Parameters		Value	Unit
R_{thjc}	Thermal resistance junction to case <i>double side cooling</i>	10.0	K/kW
	<i>anode side cooling</i>	16.0	
	<i>cathode side cooling</i>	26.5	
R_{thch}	Thermal resistance case to heatsink <i>double side cooling</i>	3.0	K/kW
	<i>single side cooling</i>	6.0	

Transient Thermal Impedance						
Analytical function for transient thermal impedance $Z_{thjc} = \sum_{i=1}^5 R_i (1 - \exp(-t/\tau_i))$	i	1	2	3	4	5
	τ_i (s)	0.4871	0.1468	0.0677	0.0079	0.0021
	R_i (K/kW)	6.73	1.44	0.65	0.84	0.32
Conditions: $F_m = 50 \pm 5$ kN, Double side cooled						
Correction for periodic waveforms 180° sine: add 1.0 K/kW 180° rectangular: add 1.0 K/kW 120° rectangular: add 1.5 K/kW 60° rectangular: add 3.0 K/kW						
Fig. 2 <i>Dependence transient thermal impedance junction to case on square pulse</i>						

On-State Characteristics

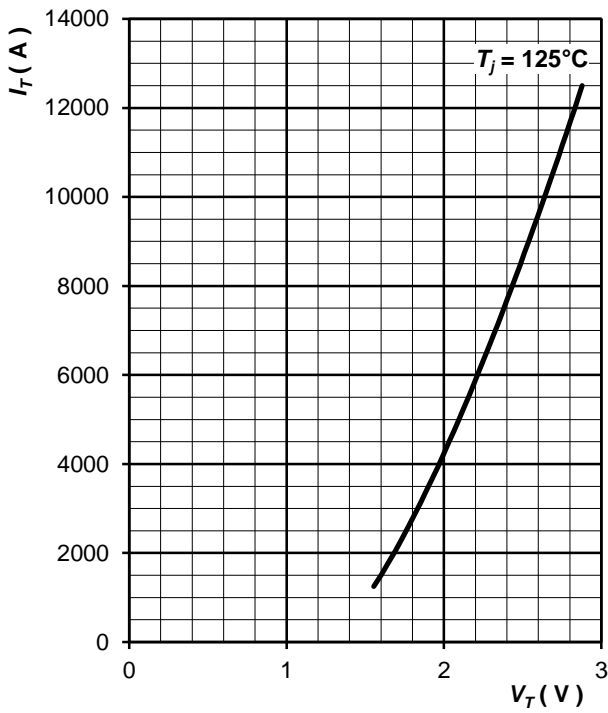


Fig. 3 Maximum on-state characteristics

Gate Trigger Characteristics

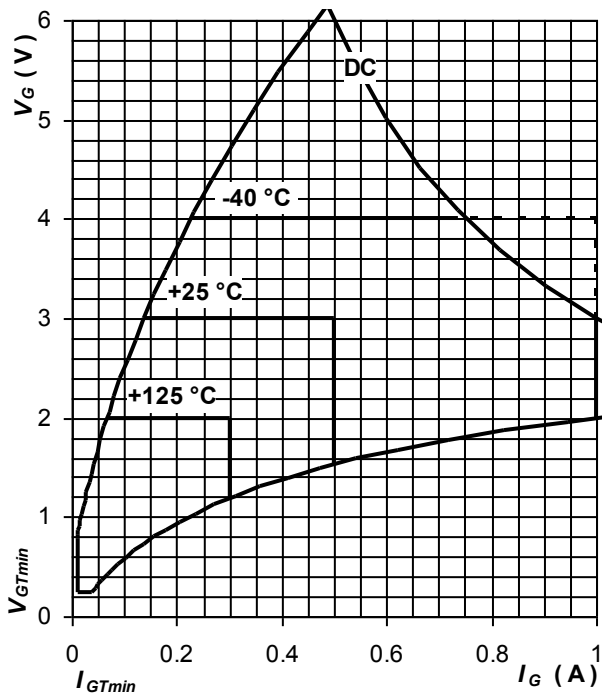


Fig. 4 Gate trigger characteristics

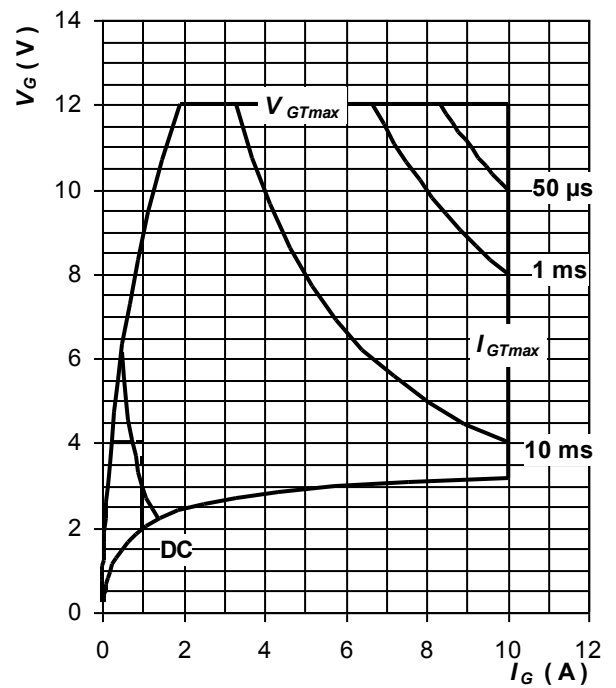


Fig. 5 Maximum peak gate power loss

Surge Characteristics

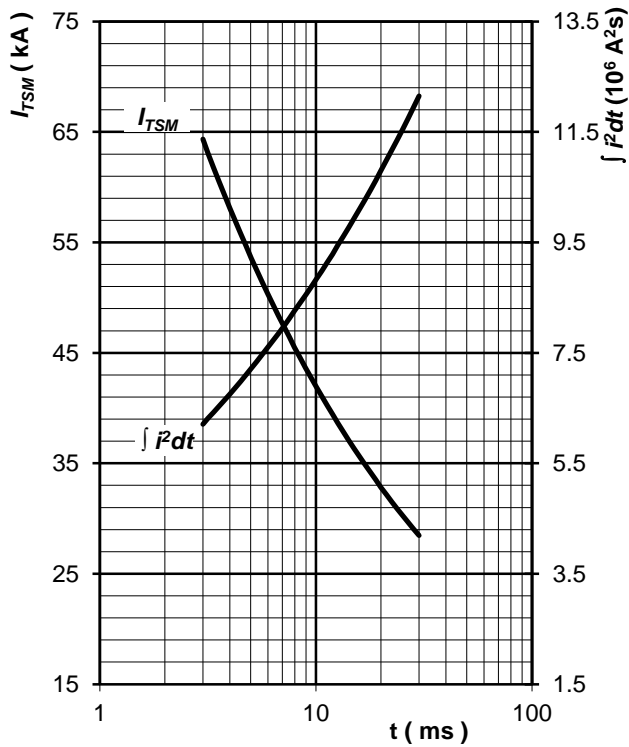


Fig. 6 Surge on-state current vs. pulse length, half sine wave, single pulse, $V_R = 0 V$, $T_j = T_{jmax}$

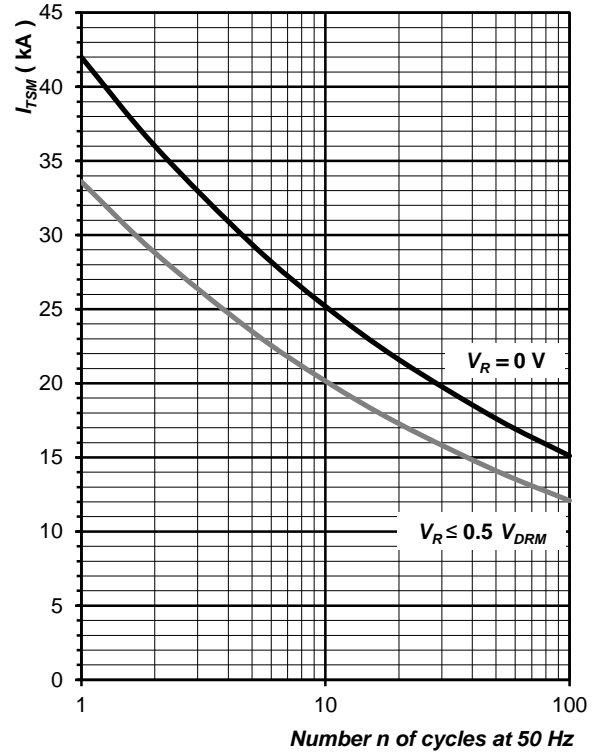


Fig. 7 Surge on-state current vs. number of pulses, half sine wave, $T_j = T_{jmax}$

Power Loss and Maximum Case Temperature Characteristics

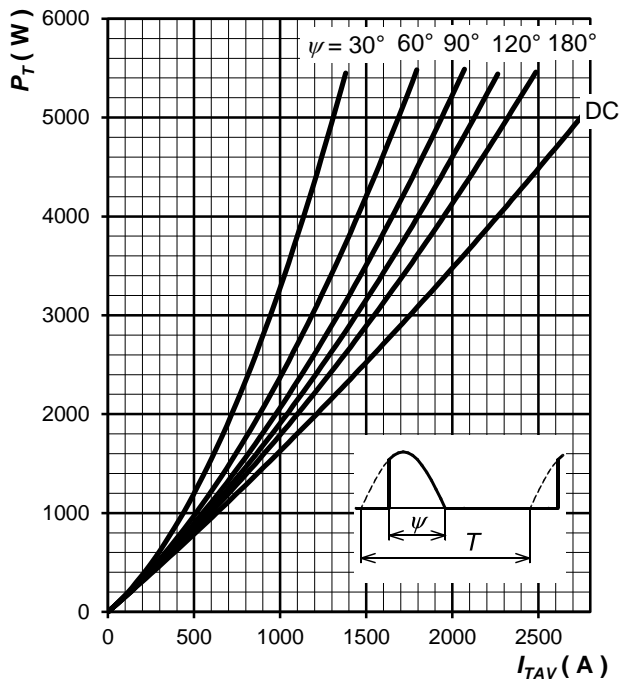


Fig. 8 On-state power loss vs. average on-state current, sine waveform, $f = 50 \text{ Hz}$, $T = 1/f$

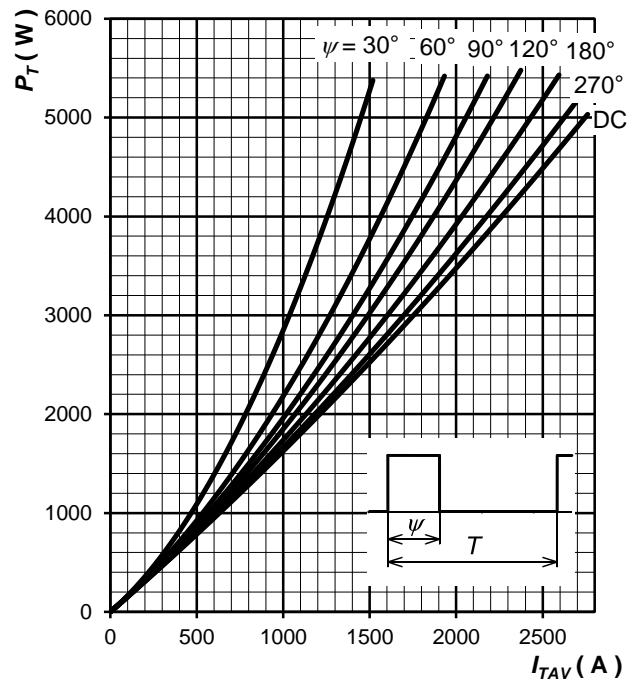


Fig. 9 On-state power loss vs. average on-state current, square waveform, $f = 50 \text{ Hz}$, $T = 1/f$

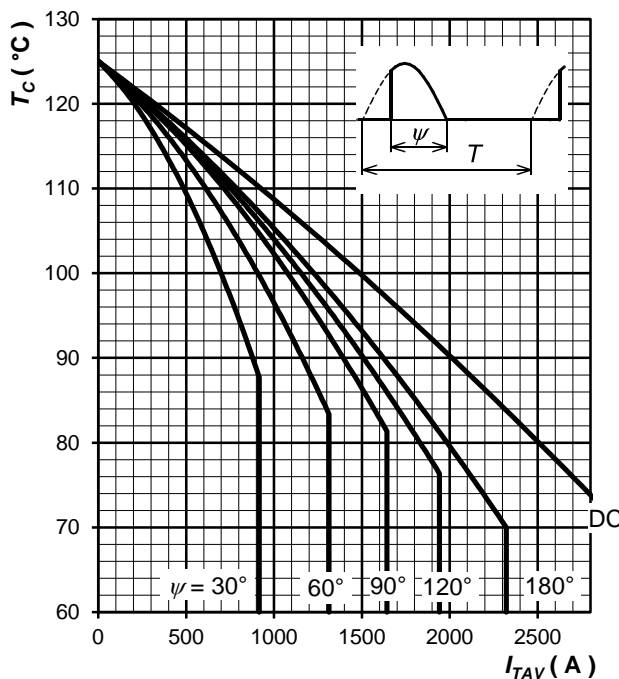


Fig. 10 Max. case temperature vs. aver. on-state current, sine waveform, $f = 50 \text{ Hz}$, $T = 1/f$

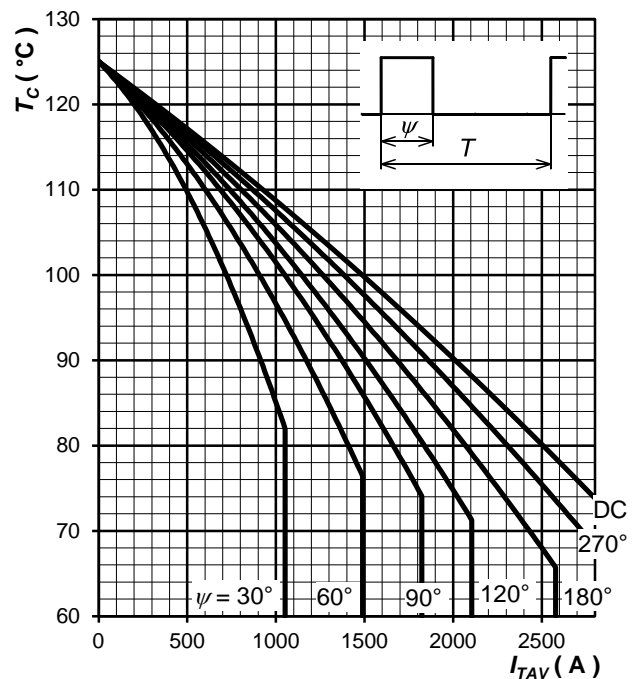


Fig. 11 Max. case temperature vs. aver. on-state current, square waveform, $f = 50 \text{ Hz}$, $T = 1/f$

Note 2: Figures number 8 ÷ 11 have been calculated without considering any turn-on and turn-off losses. They are valid for $f = 50$ or 60 Hz operation.

Turn-off Time, Parameter Relationship

Maximum values of turn-off time at application specific conditions are given by using this formula:

$$t_q = t_{q1} \cdot \frac{t_q}{t_{q1}}(T_j) \cdot \frac{t_q}{t_{q1}}(dv_D / dt) \cdot \frac{t_q}{t_{q1}}(-di_T / dt)$$

where:

t_{q1} is turn-off time at standard conditions, see section "Characteristics"

$\frac{t_q}{t_{q1}}(T_j)$ is factor to be taken from fig. 12

$\frac{t_q}{t_{q1}}(dv_D / dt)$ is factor to be taken from fig. 13

$\frac{t_q}{t_{q1}}(-di_T / dt)$ is factor to be taken from fig. 14

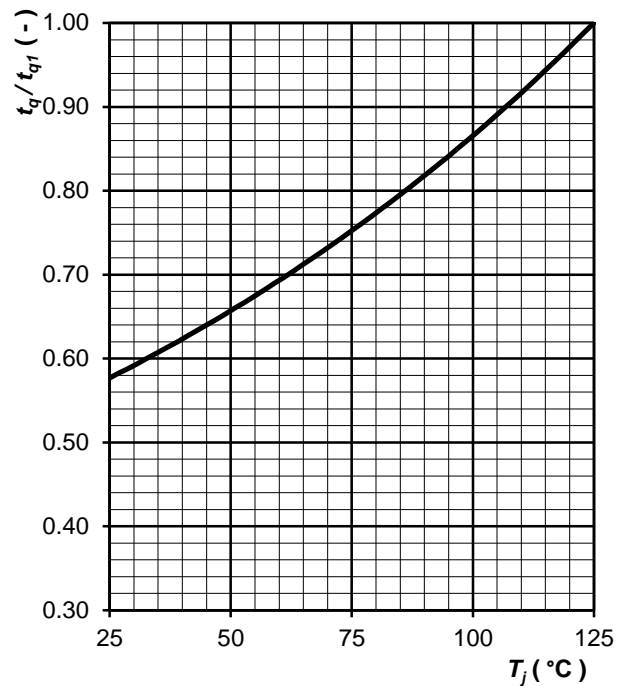


Fig. 12 Normalised maximum turn-off time vs. junction temperature

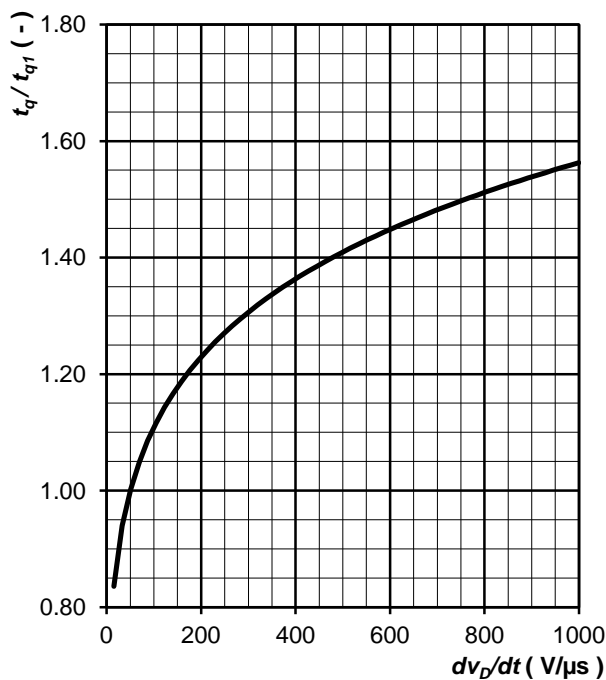


Fig. 13 Normalised maximum turn-off time vs. rate of rise of off-state voltage

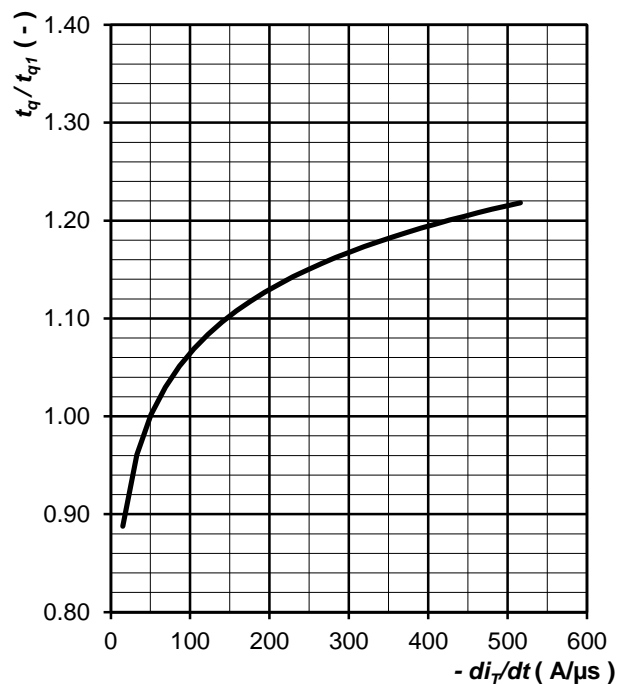


Fig. 14 Normalised maximum turn-off time vs. rate of fall of on-state current

Turn-off Characteristics

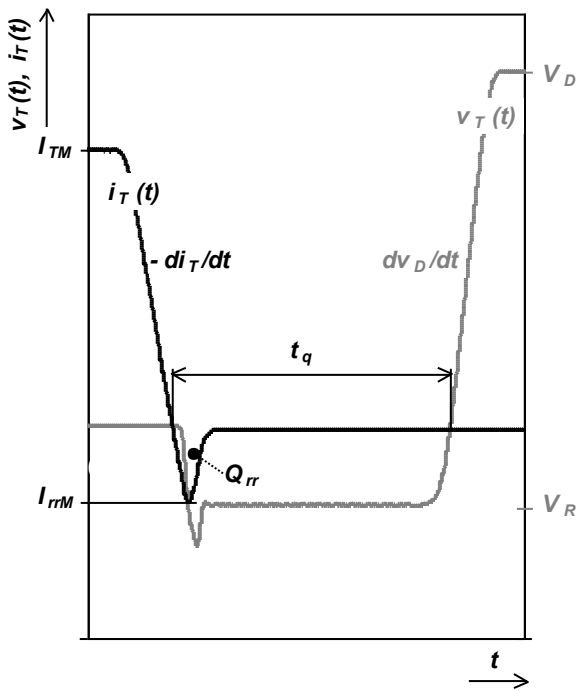


Fig. 17 Typical waveforms and definition of symbols at turn-off of a thyristor, inductive switching without RC snubber

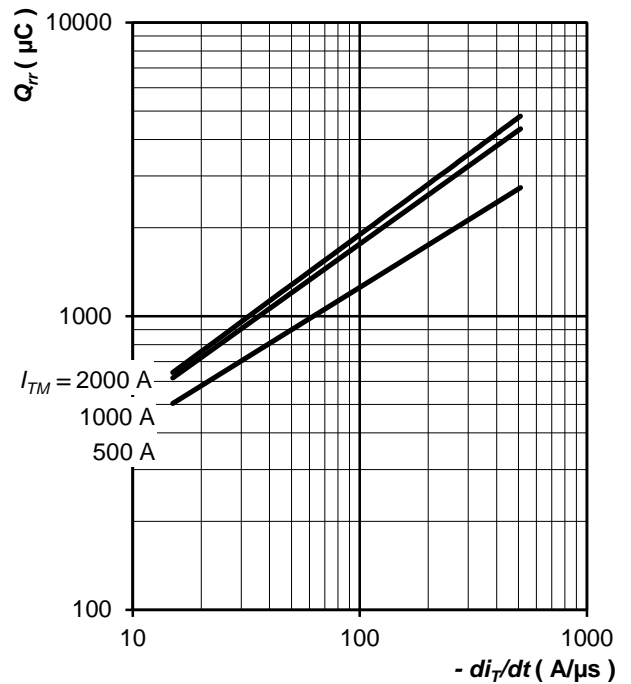


Fig. 18 Max. recovered charge vs. rate of fall on-state current, trapezoid pulse, $V_R = 100 \text{ V}$, $T_j = T_{jmax}$

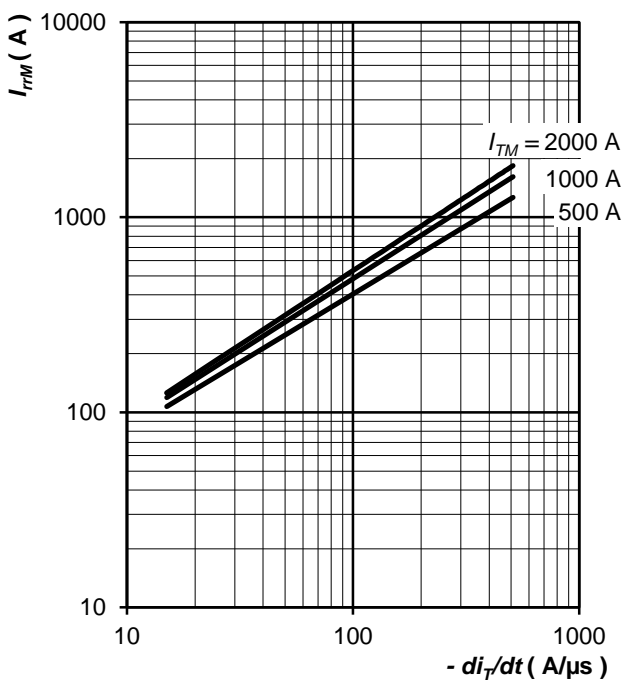


Fig. 19 Max. reverse recovery current vs. rate of fall on-state current, trapezoid pulse, $V_R = 100 \text{ V}$, $T_j = T_{jmax}$

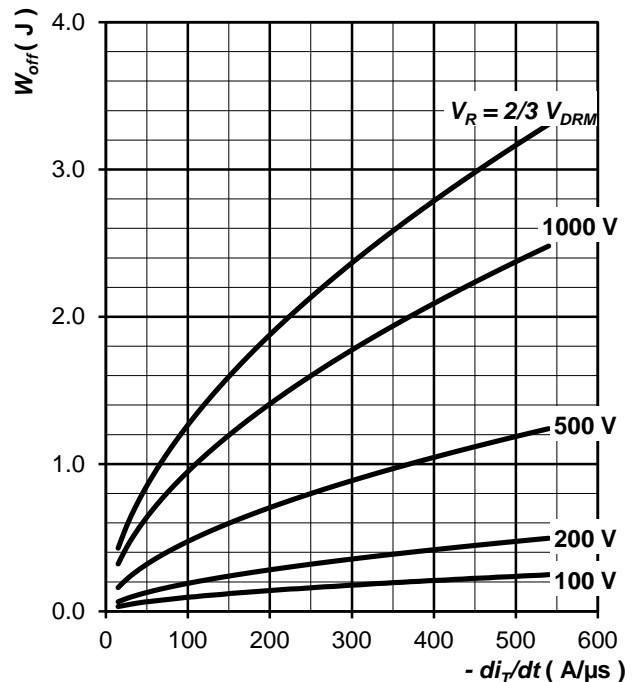


Fig. 20 Maximum turn-off energy per pulse vs. rate of fall on-state current, trapezoid pulse, inductive switching without RC snubber, $I_{TM} = 2\ 000 \text{ A}$, $T_j = T_{jmax}$

Notes:

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